

Preliminary W39L040



512K \times 8 CMOS FLASH MEMORY

GENERAL DESCRIPTION

The W39L040 is a 4Mbit, 3.3-volt only CMOS flash memory organized as $512K \times 8$ bits. For flexible erase capability, the 4Mbits of data are divided into 8 uniform sectors of 64 Kbytes, which are composed of 16 smaller even pages with 4 Kbytes. The byte-wide ($\times 8$) data appears on DQ7–DQ0. The device can be programmed and erased in-system with a standard 3.3V power supply. A 12-volt VPP is not required. The unique cell architecture of the W39L040 results in fast program/erase operations with extremely low current consumption (compared to other comparable 3.3-volt flash memory products). The device can also be programmed and erased by using standard EPROM programmers.

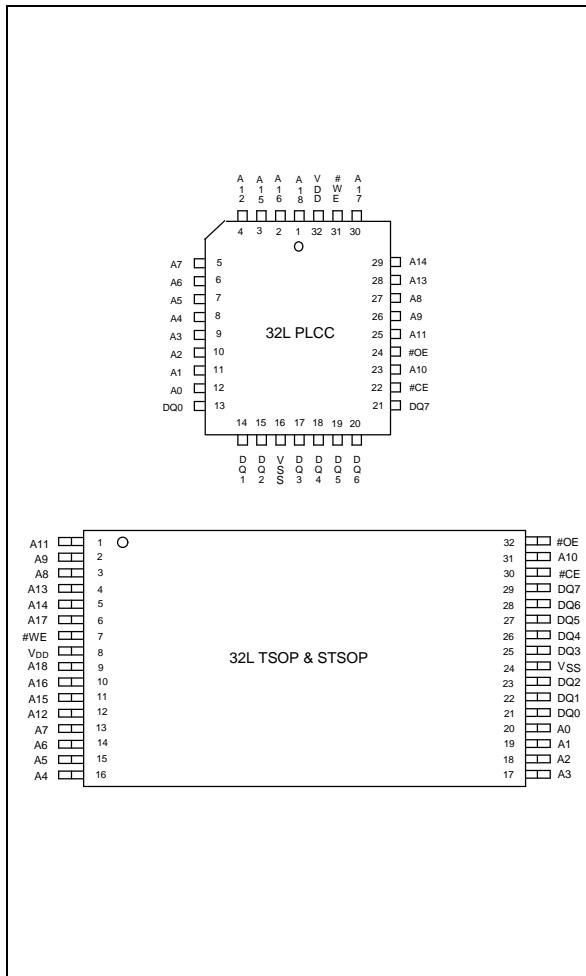
FEATURES

- Single 3.3-volt operations
 - 3.3-volt Read
 - 3.3-volt Erase
 - 3.3-volt Program
- Fast Program operation:
 - Byte-by-Byte programming: 50 μ S (max.)
- Fast Erase operation:
 - Chip Erase cycle time: 100 mS (max.)
 - Sector Erase cycle time: 25 mS (max.)
 - Page Erase cycle time: 25 mS (max.)
- Read access time: 70/90 nS
- 8 Even sectors with 64K bytes each, which is composed of 16 flexible pages with 4K bytes
- Any individual sector or page can be erased
- Hardware protection:
 - Optional 16K byte or 64K byte Top/Bottom Boot Block with lockout protection
- Flexible 4K-page size can be used as Parameter Blocks
- Typical program/erase cycles: 1K/10K
- Twenty-year data retention
- Low power consumption
 - Active current: 10 mA (typ.)
 - Standby current: 15 μ A (typ.)
- End of program detection
 - Software method: Toggle bit/Data polling
- TTL compatible I/O
- JEDEC standard byte-wide pinouts
- Available packages: 32L PLCC, 32L TSOP (8 x 20 mm) and 32L STSOP (8 x 14 mm)

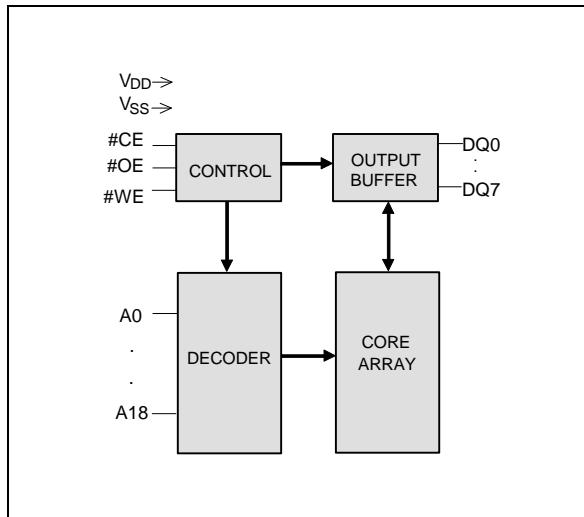
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PIN CONFIGURATIONS



BLOCK DIAGRAM



PIN DESCRIPTION

SYMBOL	PIN NAME
A0 – A18	Address Inputs
DQ0 – DQ7	Data Inputs/Outputs
#CE	Chip Enable
#OE	Output Enable
#WE	Write Enable
VDD	Power Supply
VSS	Ground



FUNCTIONAL DESCRIPTION

Device Bus Operation

Read Mode

The read operation of the W39L040 is controlled by #CE and #OE, both of which have to be low for the host to obtain data from the outputs. #CE is used for device selection. When #CE is high, the chip is de-selected and only standby power will be consumed. #OE is the output control and is used to gate data from the output pins. The data bus is in high impedance state when either #CE or #OE is high. Refer to the timing waveforms for further details.

Write Mode

Device erasure and programming are accomplished via the command register. The contents of the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device.

The command register itself does not occupy any addressable memory location. The register is a latch used to store the commands, along with the address and data information needed to execute the command. The command register is written by bringing #WE to logic low state, while #CE is at logic low state and #OE is at logic high state. Addresses are latched on the falling edge of #WE or #CE, whichever happens later; while data is latched on the rising edge of #WE or #CE, whichever happens first. Standard microprocessor write timings are used.

Refer to AC Write Characteristics and the Erase/Programming Waveforms for specific timing parameters.

Standby Mode

There are two ways to implement the standby mode on the W39L040 device, both using the #CE pin.

A CMOS standby mode is achieved with the #CE input held at $V_{DD} \pm 0.3V$. Under this condition the current is typically reduced to less than 15 μA (max). A TTL standby mode is achieved with the #CE pin held at VIH.

Under this condition the current is typically reduced to 2 mA(max).

In the standby mode the outputs are in the high impedance state, independent of the #OE input.

Output Disable Mode

With the #OE input at a logic high level (VIH), output from the device is disabled. This will cause the output pins to be in a high impedance state.

Auto-select Mode

The auto-select mode allows the reading of a binary code from the device and will identify its manufacturer and type. This mode is intended for use by programming equipment for the purpose of automatically matching the device to be programmed with its corresponding programming algorithm. This mode is functional over the entire temperature range of the device.

To activate this mode, the programming equipment must force VID (11.5V to 12.5V) on address pin A9. Two identifier bytes may then be sequenced from the device outputs by toggling address A0 from VIL to VIH. All addresses are don't cares except A0 and A1 (see "Auto-select Codes").

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The manufacturer and device codes may also be read via the command register, for instance, when the W39L040 is erased or programmed in a system without access to high voltage on the A9 pin. The command sequence is illustrated in "Auto-select Codes".

Byte 0 (A0 = VIL) represents the manufacturer's code (Winbond = DAH) and byte 1 (A0 = VIH) the device identifier code (W39L040 = B6hex). All identifiers for manufacturer and device will exhibit odd parity with DQ7 defined as the parity bit. In order to read the proper device codes when executing the Auto-select, A1 must be low state.

Data Protection

The W39L040 is designed to offer protection against accidental erasure or programming caused by spurious system level signals that may exist during power transitions. During power up the device automatically resets the internal state machine in the Read mode. Also, with its control register architecture, alteration of the memory contents only occurs after successful completion of specific multi-bus cycle command sequences. The device also incorporates several features to prevent inadvertent write cycles resulting from VDD power-up and power-down transitions or system noise.

Boot Block Operation

There are four alternatives to set the boot block. Either 16K-byte or 64K-byte in the top/bottom location of this device can be locked as boot block, which can be used to store boot codes. It is located in the last 16K/64K bytes or first 16K/64K bytes of the memory with the address range from 7C000/70000(hex) to 7FFFF(hex) for top location or 00000(hex) to 03FFF/0FFFF(hex) for bottom location.

See Command Codes for Boot Block Lockout Enable for the specific code. Once this feature is set the data for the designated block cannot be erased or programmed (programming lockout), other memory locations can be changed by the regular programming method.

In order to detect whether the boot block feature is set on the first/last 16K/64K-bytes block or not, users can perform software command sequence: enter the product identification mode (see Command Codes for Identification/Boot Block Lockout Detection for specific code), and then read from address 0002(hex) for first(bottom) location or 7FFF2(hex) for last(top) location. If the DQ0/DQ1 of output data is "1/0," the 16Kbytes boot block programming lockout feature will be activated; If the DQ0/DQ1 of output data is "1/1," the 16Kbytes boot block programming lockout feature will be activated. If the DQ0/DQ1 of output data is "0/0," the lockout feature will be inactivated and the block can be erased/programmed.

To return to normal operation, perform a three-byte command sequence (or an alternate single-byte command) to exit the identification mode. For the specific code, see Command Codes for Identification/Boot Block Lockout Detection.

Low VDD Inhibit

To avoid initiation of a write cycle during VDD power-up and power-down, the W39L040 locks out when $VDD < 2.0V$ (see DC Characteristics section for voltages). The write and read operations are inhibited when VDD is less than 2.0V typical. The W39L040 ignores all write and read operations until $VDD > 2.0V$. The user must ensure that the control pins are in the correct logic state when $VDD > 2.0V$ to prevent unintentional writes.

Write Pulse "Glitch" Protection

Noise pulses of less than 10 nS (typical) on #OE, #CE, or #WE will not initiate a write cycle.



Logical Inhibit

Writing is inhibited by holding any one of #OE = VIL, #CE = VIH, or #WE = VIH. To initiate a write cycle #CE and #WE must be a logical zero while #OE is a logical one.

Power-up Write and Read Inhibit

Power-up of the device with #WE = #CE = VIL and #OE = VIH will not accept commands on the rising edge of #WE except 5mS delay (see the power up timing in AC Characteristics). The internal state machine is automatically reset to the read mode on power-up.

Command Definitions

Device operations are selected by writing specific address and data sequences into the command register. Writing incorrect address and data values or writing them in the improper sequence will reset the device to the read mode. "Command Definitions" defines the valid register command sequences.

Read Command

The device will automatically power-up in the read state. In this case, a command sequence is not required to read data. Standard microprocessor read cycles will retrieve array data. This default value ensures that no spurious alteration of the memory content occurs during the power transition.

The device will automatically return to read state after completing an Embedded Program or Embedded Erase algorithm.

Refer to the AC Read Characteristics and Waveforms for the specific timing parameters.

Auto-select Command

Flash memories are intended for use in applications where the local CPU can alter memory contents. As such, manufacture and device codes must be accessible while the device resides in the target system. PROM programmers typically access the signature codes by raising A9 to a high voltage. However, multiplexing high voltage onto the address lines is not generally a desirable system design practice.

The device contains an auto-select command operation to supplement traditional PROM programming methodology. The operation is initiated by writing the auto-select command sequence into the command register. Following the command write, a read cycle from address XX00H retrieves the manufacture code of DAH. A read cycle from address XX01H returns the device code (W39L040 = B6hex).

To terminate the operation, it is necessary to write the auto-select exit command sequence into the register.

Byte Program Command

The device is programmed on a byte-by-byte basis. Programming is a four-bus-cycle operation. The program command sequence is initiated by writing two "unlock" write cycles, followed by the program set-up command. The program address and data are written next, which in turn initiate the Embedded program algorithm. Addresses are latched on the falling edge of #CE or #WE, whichever happens later and the data is latched on the rising edge of #CE or #WE, whichever happens first. The rising edge of #CE or #WE (whichever happens first) begins programming using the Embedded Program Algorithm. Upon executing the algorithm, the system is not required to provide further controls or timings. The



device will automatically provide adequate internally generated program pulses and verify the programmed cell margin.

The automatic programming operation is completed when the data on DQ7 (also used as Data Polling) is equivalent to the data written to this bit at which time the device returns to the read mode and addresses are no longer latched (see "Hardware Sequence Flags"). Therefore, the device requires that a valid address to the device be supplied by the system at this particular instance of time for Data Polling operations. Data Polling must be performed at the memory location which is being programmed.

Any commands written to the chip during the Embedded Program Algorithm will be ignored. If a hardware reset occurs during the programming operation, the data at that particular location will be corrupted.

Programming is allowed in any sequence and across sector boundaries. Beware that a data "0" cannot be programmed back to a "1". Attempting to program 0 back to 1, the toggle bit will stop toggling. Only erase operations can convert "0"s to "1"s.

Refer to the Programming Command Flow Chart using typical command strings and bus operations.

Chip Erase Command

Chip erase is a six-bus-cycle operation. There are two "unlock" write cycles, followed by writing the "set-up" command. Two more "unlock" write cycles are asserted, followed by the chip erase command.

Chip erase does not require the user to program the device prior to erase. Upon executing the Embedded Erase Algorithm command sequence the device will automatically erase and verify the entire memory for an all one data pattern. The erase is performed sequentially on each sectors at the same time (see "Feature"). The system is not required to provide any controls or timings during these operations.

The automatic erase begins on the rising edge of the last #WE pulse in the command sequence and terminates when the data on DQ7 is "1" at which time the device returns to read the mode.

Refer to the Erase Command Flow Chart using typical command strings and bus operations.

Sector/Page Erase Command

Sector/page erase is a six bus cycles operation. There are two "unlock" write cycles, followed by writing the "set-up" command. Two more "unlock" write cycles then follows by the sector erase command. The sector/page address (any address location within the desired sector/page) is latched on the falling edge of #WE, while the command (30H/50H) is latched on the rising edge of #WE.

Sector/page erase does not require the user to program the device prior to erase. When erasing a sector/page or sectors/pages the remaining unselected sectors/pages are not affected. The system is not required to provide any controls or timings during these operations.

The automatic sector/page erase begins after the erase command is completed, right from the rising edge of the #WE pulse for the last sector/page erase command pulse and terminates when the data on DQ7, Data Polling, is "1" at which time the device returns to the read mode. Data Polling must be performed at an address within any of the sectors/pages being erased.

Refer to the Erase Command flow Chart using typical command strings and bus operations.



Write Operation Status

DQ7: Data Polling

The W39L040 device features Data Polling as a method to indicate to the host that the embedded algorithms are in progress or completed.

During the Embedded Program Algorithm, an attempt to read the device will produce the complement of the data last written to DQ7. Upon completion of the Embedded Program Algorithm, an attempt to read the device will produce the true data last written to DQ7.

During the Embedded Erase Algorithm, an attempt to read the device will produce a "0" at the DQ7 output. Upon completion of the Embedded Erase Algorithm, an attempt to read the device will produce a "1" at the DQ7 output.

For chip erase, the Data Polling is valid after the rising edge of the sixth pulse in the six #WE write pulse sequences. For sector erase, the Data Polling is valid after the last rising edge of the sector erase #WE pulse. Data Polling must be performed at sector addresses within any of the sectors being erased. Otherwise, the status may not be valid.

Just prior to the completion of Embedded Algorithm operations DQ7 may change asynchronously while the output enable (#OE) is asserted low. This means that the device is driving status information on DQ7 at one instant of time and then that byte's valid data at the next instant of time. Depending on when the system samples the DQ7 output, it may read the status or valid data. Even if the device has completed the Embedded Algorithm operations and DQ7 has a valid data, the data outputs on DQ0–DQ6 may be still invalid. The valid data on DQ0–DQ7 will be read on the successive read attempts.

The Data Polling feature is only active during the Embedded Programming Algorithm, Embedded Erase Algorithm, or sector erase time-out (see "Command Definitions").

DQ6: Toggle Bit

The W39L040 also features the "Toggle Bit" as a method to indicate to the host system that the embedded algorithms are in progress or completed.

During an Embedded Program or Erase Algorithm cycle, successive attempts to read (#OE toggling) data from the device at any address will result in DQ6 toggling between one and zero. Once the Embedded Program or Erase Algorithm cycle is completed, DQ6 will stop toggling and valid data will be read on the next successive attempt. During programming, the Toggle Bit is valid after the rising edge of the fourth #WE pulse in the four write pulse sequence. For chip erase, the Toggle Bit is valid after the rising edge of the sixth #WE pulse in the six write pulse sequence. For sector/page erase, the Toggle Bit is valid after the last rising edge of the sector/page erase #WE pulse. The Toggle Bit is active during the sector/page erase time-out.

Either #CE or #OE toggling will cause DQ6 to toggle.



TABLE OF OPERATING MODES

Device Bus Operations

(VID = 12 ±0.5V)

MODE	PIN						
	#CE	#OE	#WE	A0	A1	A9	DQ0 - DQ7
Read	VIL	VIL	VIH	A0	A1	A9	Dout
Write	VIL	VIH	VIL	A0	A1	A9	Din
Standby	VIH	X	X	X	X	X	High Z
Write Inhibit	X	VIL	X	X	X	X	High Z/Dout
	X	X	VIH	X	X	X	High Z/Dout
Output Disable	VIL	VIH	VIH	X	X	X	High Z
Auto select Manufacturers ID	VIL	VIL	VIH	VIL	VIL	VID	Code
Auto select Device ID	VIL	VIL	VIH	VIH	VIL	VID	Code

Auto-select Codes (High Voltage Method)

(VID = 12 ±0.5V)

DESCRIPTION	#CE	#OE	#WE	A9	THE OTHER ADDRESS	DQ[7:0]
Manufacturer ID: Winbond	VIL	VIL	VIH	VID	All Add = VIL	DAhex
Device ID: W39L040	VIL	VIL	VIH	VID	A1= VIH, All other = VIL	B6hex

Sector Address Table

SECTOR	A18	A17	A16	SECTOR SIZE (KBYTES)	ADDRESS
SA0	0	0	0	64	00000h – 0FFFFh
SA1	0	0	1	64	10000h – 1FFFFh
SA2	0	1	0	64	20000h – 2FFFFh
SA3	0	1	1	64	30000h – 3FFFFh
SA4	1	0	0	64	40000h – 4FFFFh
SA5	1	0	1	64	50000h – 5FFFFh
SA6	1	1	0	64	60000h – 6FFFFh
SA7	1	1	1	64	70000h – 7FFFFh

Note: All sectors are 64K bytes in size.

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Command Definitions

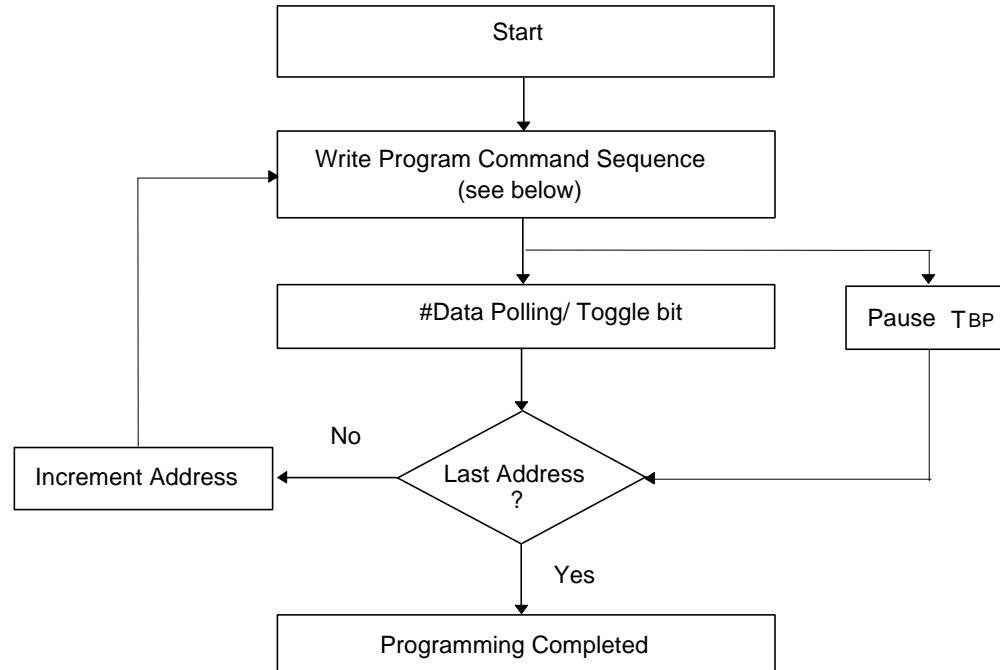
COMMAND DESCRIPTION	NO. OF Cycles	1ST CYCLE		2ND CYCLE		3RD CYCLE		4TH CYCLE		5TH CYCLE		6TH CYCLE		7TH CYCLE	
		Addr. (1)Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	Addr. Data	
Read	1	A _{IN}	D _{OUT}												
Chip Erase	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	5555	10		
Sector Erase	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	SA ⁽³⁾	30		
Page Erase	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	PA ⁽⁴⁾	50		
Byte Program	4	5555	AA	2AAA	55	5555	A0	A _{IN}	D _{IN}						
Top Boot Block Lockout – 64K/16KByte	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	5555	40/70	7FFFF XX ⁽⁵⁾	
Bottom Boot Block Lockout - 64K/16KByte	6	5555	AA	2AAA	55	5555	80	5555	AA	2AAA	55	5555	40/70	00000 XX ⁽⁵⁾	
Product ID Entry	3	5555	AA	2AAA	55	5555	90								
Product ID Exit ⁽²⁾	3	5555	AA	2AAA	55	5555	F0								
Product ID Exit ⁽²⁾	1	XXXX	F0												

Notes

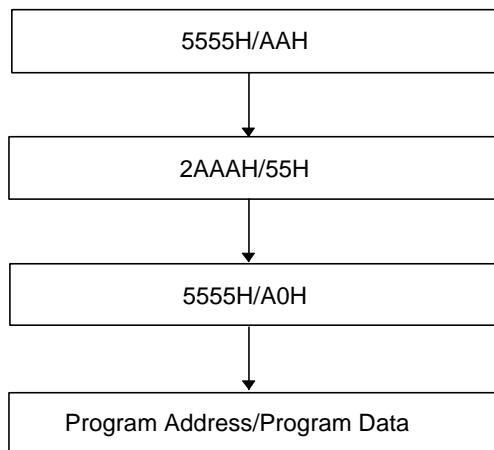
1. Address Format: A14 – A0 (Hex); Data Format: DQ7 – DQ0 (Hex)
2. Either one of the two Product ID Exit commands can be used.
3. SA: Sector Address
 - SA = 7XXXXh for Unique Sector7
 - SA = 6XXXXh for Unique Sector6
 - SA = 5XXXXh for Unique Sector5
 - SA = 4XXXXh for Unique Sector4
 - SA = 3XXXXh for Unique Sector3
 - SA = 2XXXXh for Unique Sector2
 - SA = 1XXXXh for Unique Sector1
 - SA = 0XXXXh for Unique Sector0
4. PA: Page Address

PA = 7FXXXh for Page 15 in Sector7	PA = 6FXXXh to 60xxx for Page 15 to page 0 in Sector6 (Please reference to left column)
PA = 7EXXXh for Page 14 in Sector7	PA = 5FXXXh to 50xxx for Page 15 to page 0 in Sector5 (Please reference to left column)
PA = 7DXXXh for Page 13 in Sector7	PA = 4FXXXh to 40xxx for Page 15 to page 0 in Sector4 (Please reference to left column)
PA = 7CXXXh for Page 12 in Sector7	PA = 3FXXXh to 30xxx for Page 15 to page 0 in Sector3 (Please reference to left column)
PA = 7BXXXh for Page 11 in Sector7	PA = 2FXXXh to 20xxx for Page 15 to page 0 in Sector2 (Please reference to left column)
PA = 7AXXXh for Page 10 in Sector7	PA = 1FXXXh to 10xxx for Page 15 to page 0 in Sector1 (Please reference to left column)
PA = 79XXXh for Page 9 in Sector7	PA = 0FXXXh to 00xxx for Page 15 to page 0 in Sector0 (Please reference to left column)
PA = 78XXXh for Page 8 in Sector7	
PA = 77XXXh for Page 7 in Sector7	
PA = 76XXXh for Page 6 in Sector7	
PA = 75XXXh for Page 5 in Sector7	
PA = 74XXXh for Page 4 in Sector7	
PA = 73XXXh for Page 3 in Sector7	
PA = 72XXXh for Page 2 in Sector7	
PA = 71XXXh for Page 1 in Sector7	
PA = 70XXXh for Page 0 in Sector7	
5. XX: Don't care

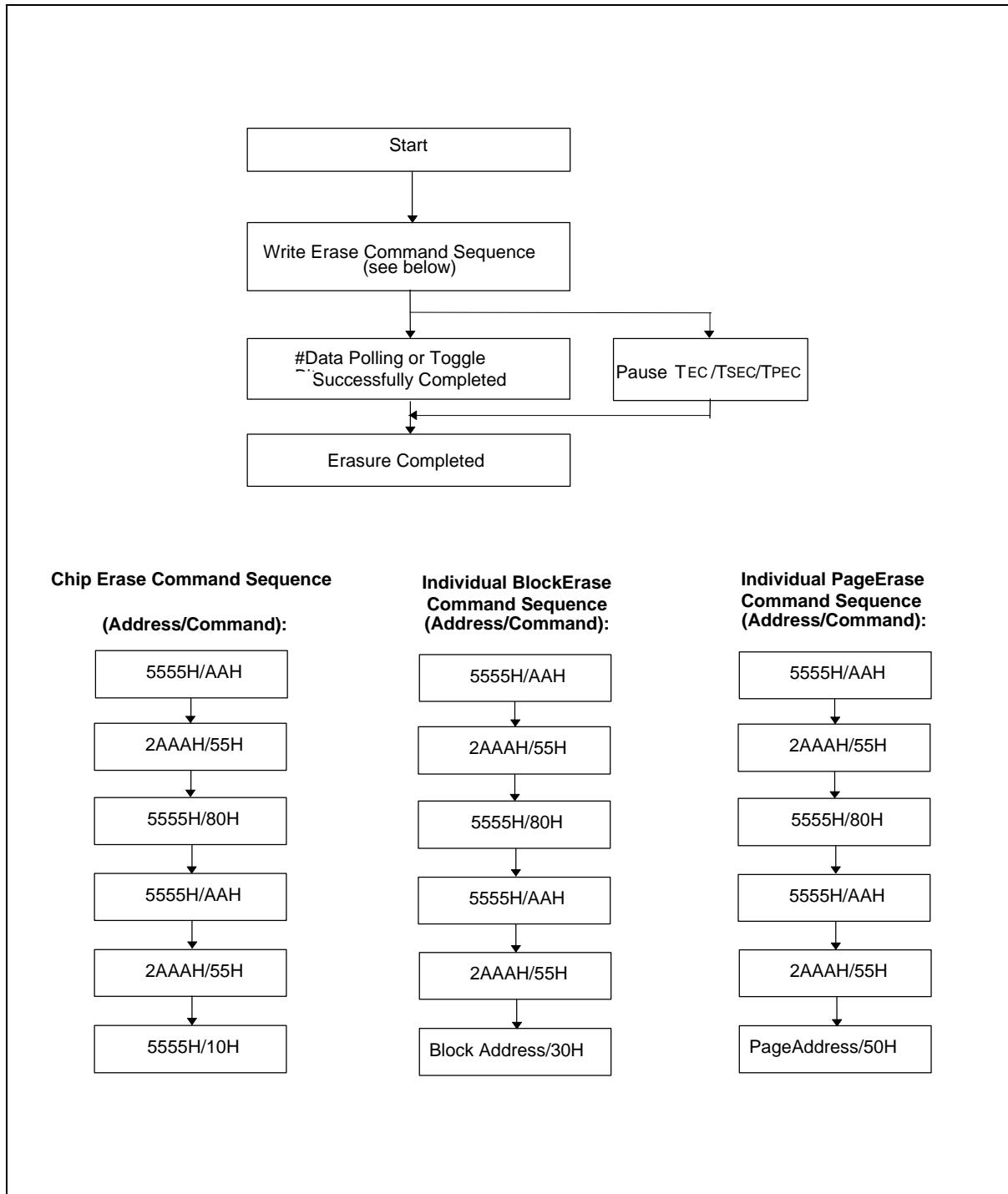
Embedded Programming Algorithm



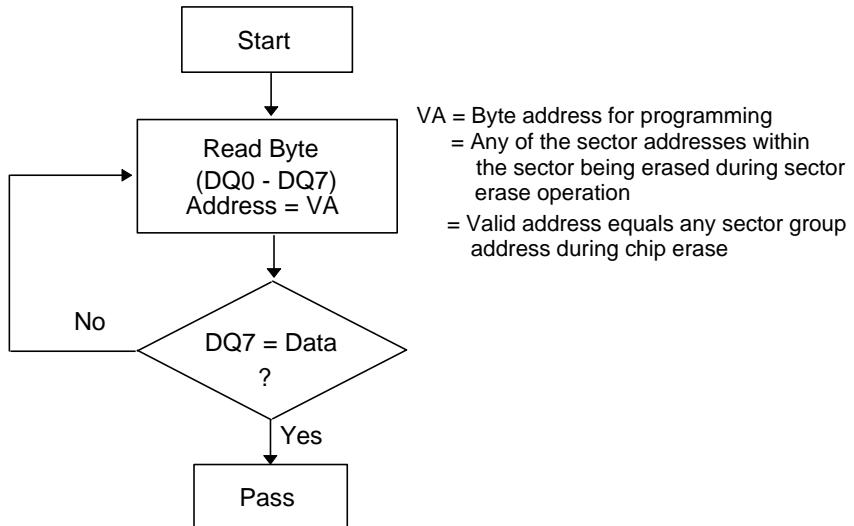
Program Command Sequence (Address/Command):



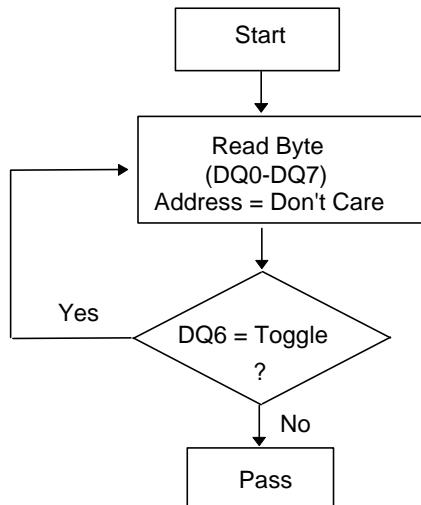
Embedded Erase Algorithm



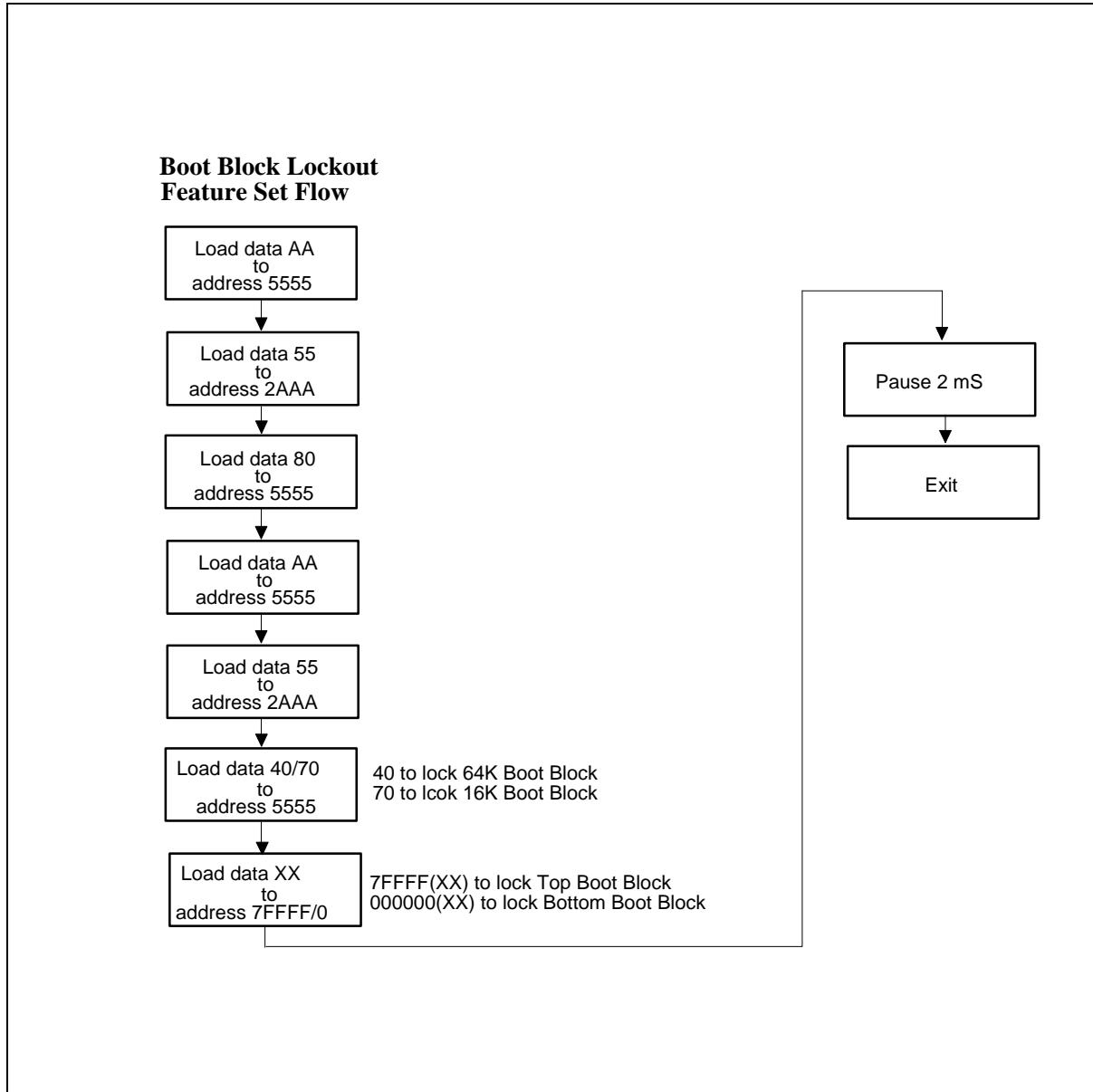
Embedded #Data Polling Algorithm



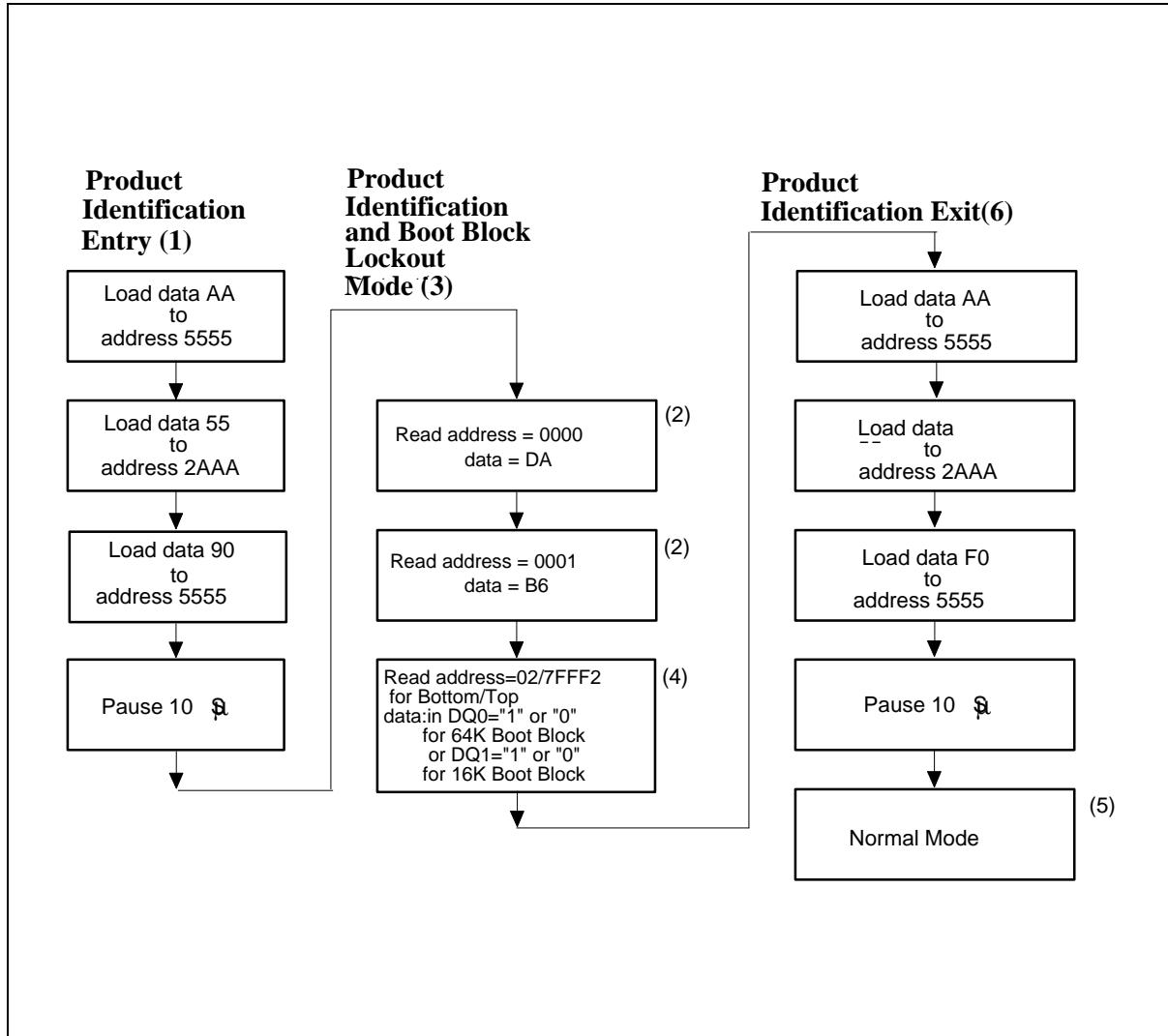
Embedded Toggle Bit Algorithm



Boot Block Lockout Enable Flow Chart



Software Product Identification and Boot Block Lockout Detection Flow Chart



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DC CHARACTERISTICS

Absolute maximum Ratings

PARAMETER	RATING	UNIT
Power Supply Voltage to Vss Potential	-2.0 to +4.6	V
Operating Temperature	0 to +70	°C
	-40 to +85	°C
Storage Temperature	-65 to +125	°C
Voltage on Any Pin to Ground Potential except A9	-2.0 to +4.6	V
Voltage on A9 Pin to Ground Potential	-2.0 to +13.0	V

Note: Exposure to conditions beyond those listed under Absolute maximum Ratings may adversely affect the life and reliability of the device.

DC Operating Characteristics

(VDD = 3.3V ±0.3V, Vss = 0V, TA = 0 to 70° C or -40 to 85° C)

PARAMETER	SYM.	TEST CONDITIONS	LIMITS			UNIT
			MIN.	TYP.	MAX.	
Power Supply Current	IDD	#CE =#OE = VIL, #WE = VIH, all DQs open, Address inputs = VIL/VIH, at f = 5 MHz	-	10	20	mA
Standby VDD Current (TTL input)	ISB1	#CE = VIH, all DQs open Other inputs = VIL/VIH	-	1	2	mA
Standby VDD Current (CMOS input)	ISB2	#CE = VDD -0.3V, all DQs open Other inputs = VDD -0.3V/ VSS	-	15	50	μA
Input Leakage Current	ILI	VIN = VSS to VDD	-	-	1	μA
Output Leakage Current	ILO	VOUT = VSS to VDD	-	-	1	μA
Input Low Voltage	VIL	-	-0.3	-	0.8	V
Input High Voltage	VIH	-	2.0	-	VDD +0.5	V
Output Low Voltage	VOL	IOL = 2.1 mA	-	-	0.45	V
Output High Voltage	VOH	IOH = -0.4 mA	2.4	-	-	V

Pin Capacitance

(VDD = 3.3V, TA = 25° C, f = 1 MHz)

PARAMETER	SYMBOL	CONDITIONS	TYP.	MAX.	UNIT
Input Capacitance	CIN	VIN = 0V	6	8	pF
Output Capacitance	COUT	VOUT = 0V	10	12	pF

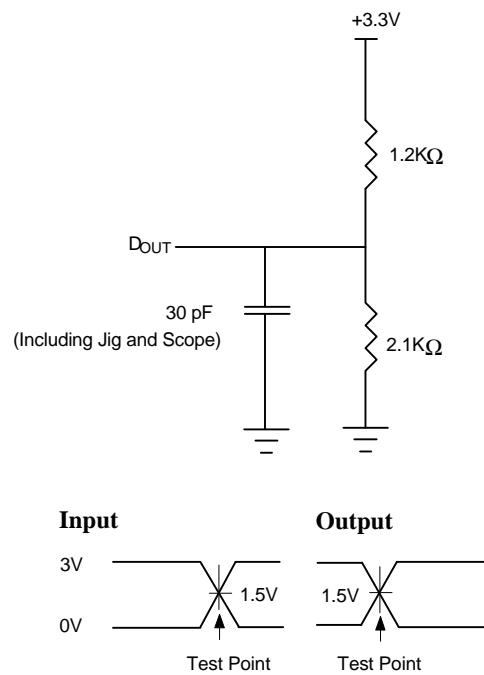


AC CHARACTERISTICS

AC Test Conditions

PARAMETER	CONDITIONS
Input Pulse Levels	0V to 3V
Input Rise/Fall Time	<5 nS
Input/Output Timing Level	1.5V/1.5V
Output Load	1 TTL Gate and $C_L = 30 \text{ pF}$

AC Test Load and Waveform



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AC Characteristics, continued

Read Cycle Timing Parameters

(V_{DD} = 3.3V ±0.3V, V_{SS} = 0V, T_A = 0 to 70° C or -40 to 85° C)

PARAMETER	SYM.	W39L040-70		W39L040-90		UNIT
		MIN.	MAX.	MIN.	MAX.	
Read Cycle Time	TRC	70	-	90	-	nS
Chip Enable Access Time	TCE	-	70	-	90	nS
Address Access Time	TAA	-	70	-	90	nS
Output Enable Access Time	TOE	-	35	-	45	nS
#CE Low to Active Output	TCLZ	0	-	0	-	nS
#OE Low to Active Output	TOLZ	0	-	0	-	nS
#CE High to High-Z Output	TCHZ	-	25	-	25	nS
#OE High to High-Z Output	TOHZ	-	25	-	25	nS
Output Hold from Address Change	TOH	0	-	0	-	nS

Write Cycle Timing Parameters

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Address Setup Time	TAS	0	-	-	nS
Address Hold Time	TAH	40	-	-	nS
#WE and #CE Setup Time	TCS	0	-	-	nS
#WE and #CE Hold Time	TCH	0	-	-	nS
#OE High Setup Time	TOES	0	-	-	nS
#OE High Hold Time	TOEH	0	-	-	nS
#CE Pulse Width	TCP	100	-	-	nS
#WE Pulse Width	TWP	100	-	-	nS
#WE High Width	TWPH	100	-	-	nS
Data Setup Time	TDS	40	-	-	nS
Data Hold Time	TDH	10	-	-	nS
Byte Programming Time	TBP	-	35	50	μS
Chip Erase Cycle Time	TEC	-	50	100	mS
Sector/Page Erase Cycle Time	TEP	-	12.5	25	mS

Note: All AC timing signals observe the following guidelines for determining setup and hold times:

(a) High level signal's reference level is V_{IH} and (b) low level signal's reference level is V_{IL}.

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AC Characteristics, continued

Power-up Timing

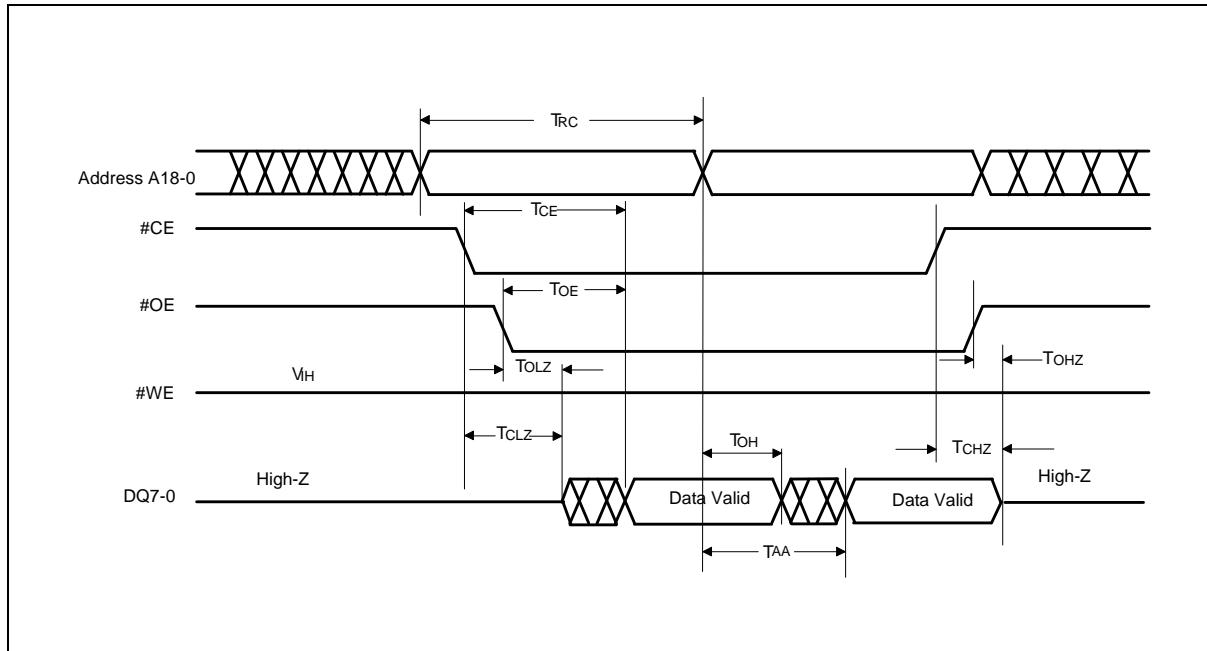
PARAMETER	SYMBOL	TYPICAL	UNIT
Power-up to Read Operation	TPU. READ	100	μS
Power-up to Write Operation	TPU. WRITE	5	mS

Data Polling and Toggle Bit Timing Parameters

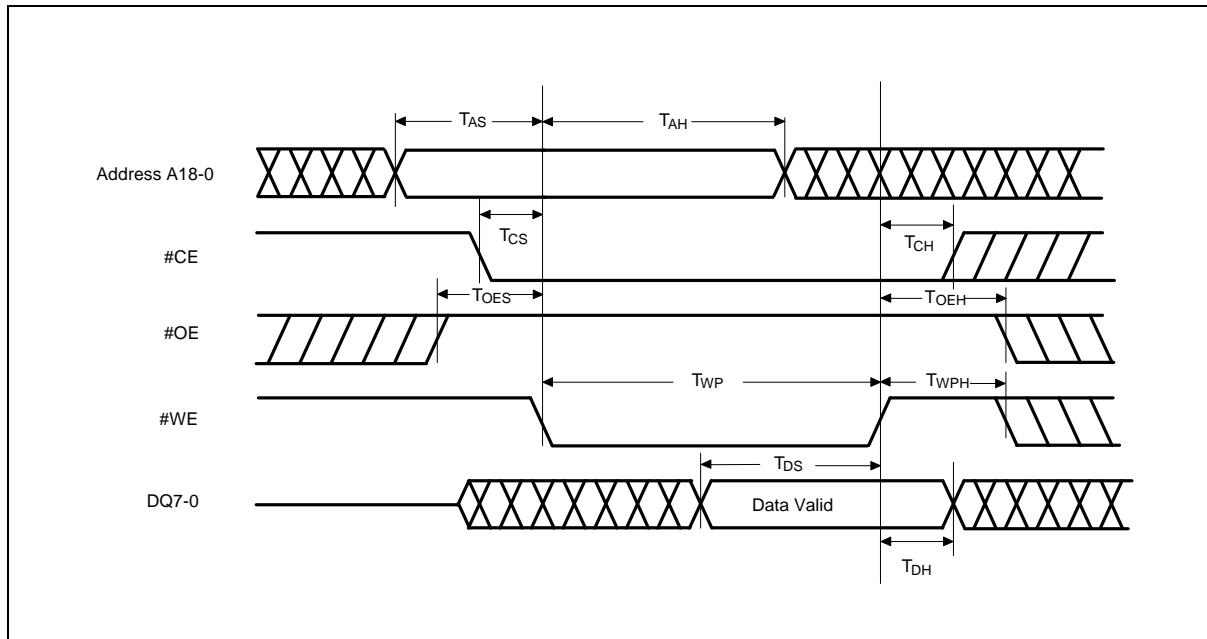
PARAMETER	SYM.	W39L040-70		W39L040-90		UNIT
		MIN.	MAX.	MIN.	MAX.	
#OE to Data Polling Output Delay	TOEP	-	35	-	45	nS
#CE to Data Polling Output Delay	TCEP	-	70	-	90	nS
#OE to Toggle Bit Output Delay	TOET	-	35	-	45	nS
#CE to Toggle Bit Output Delay	TCET	-	70	-	90	nS

TIMING WAVEFORMS

Read Cycle Timing Diagram

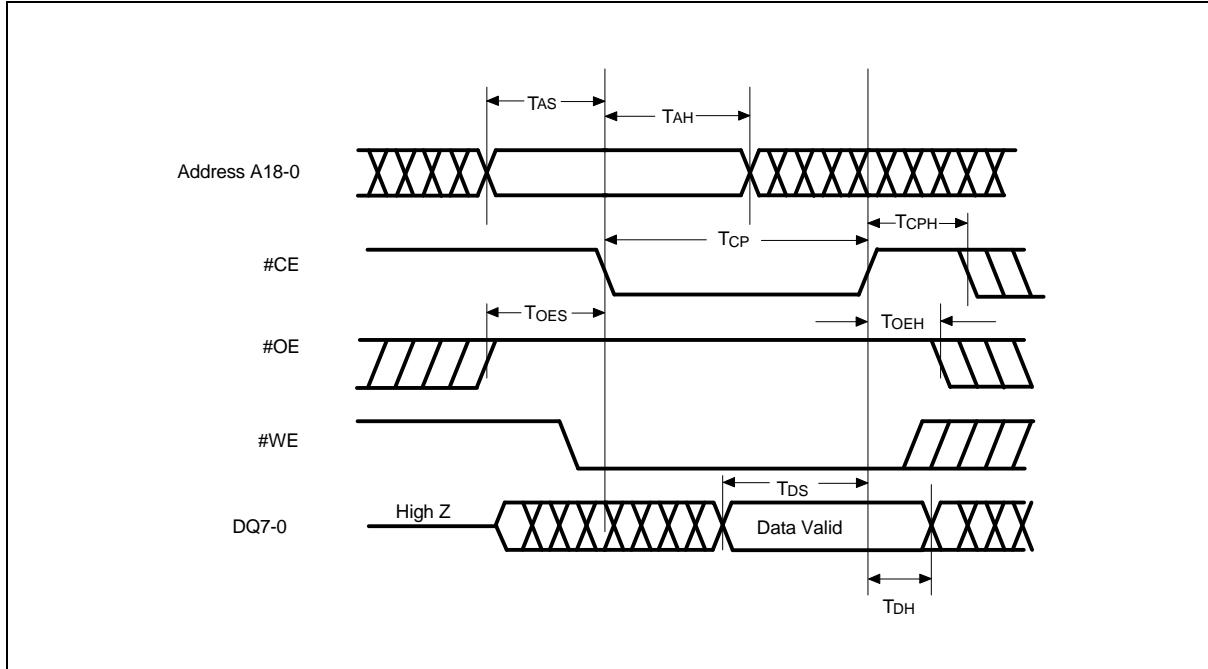


#WE Controlled Command Write Cycle Timing Diagram

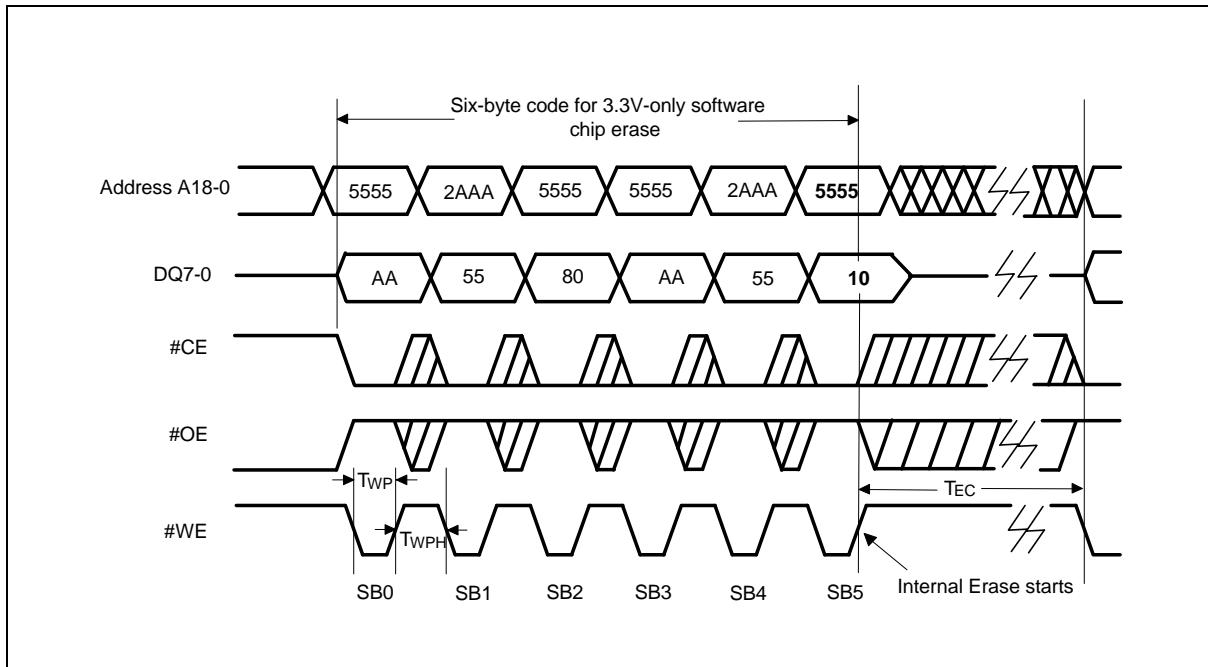


Timing Waveforms, continued

#CE Controlled Command Write Cycle Timing Diagram

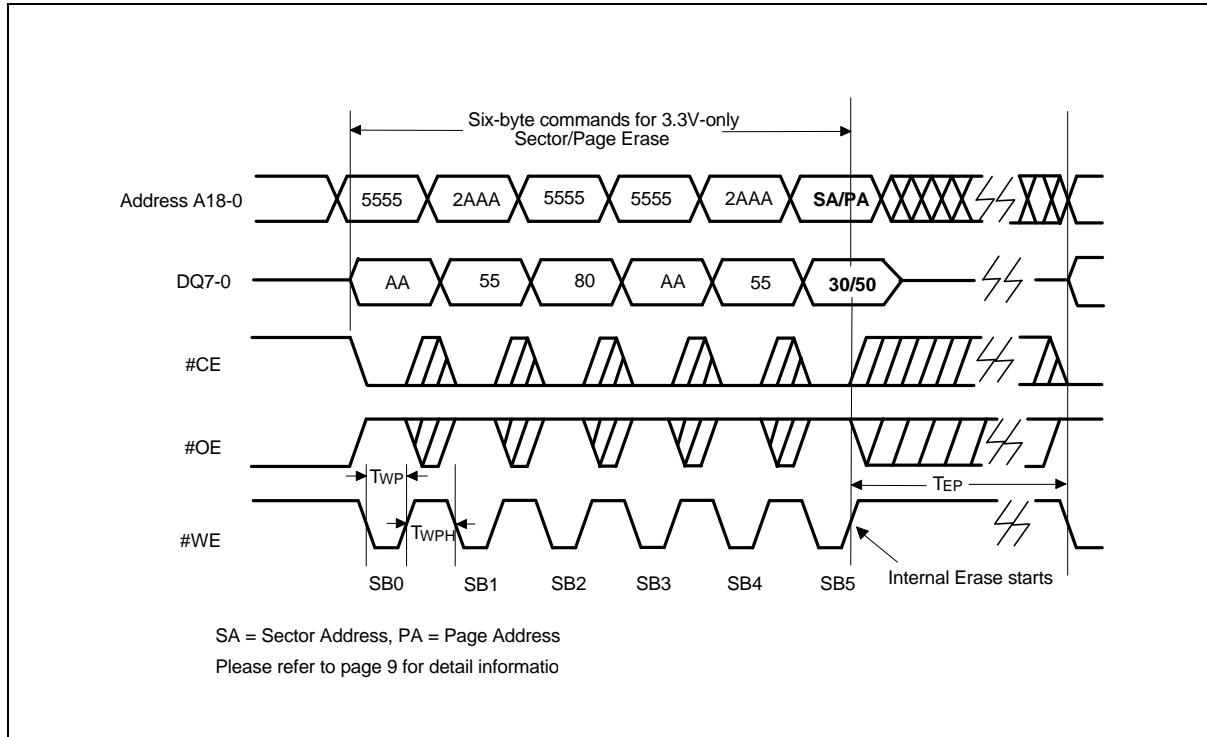


Chip Erase Timing Diagram

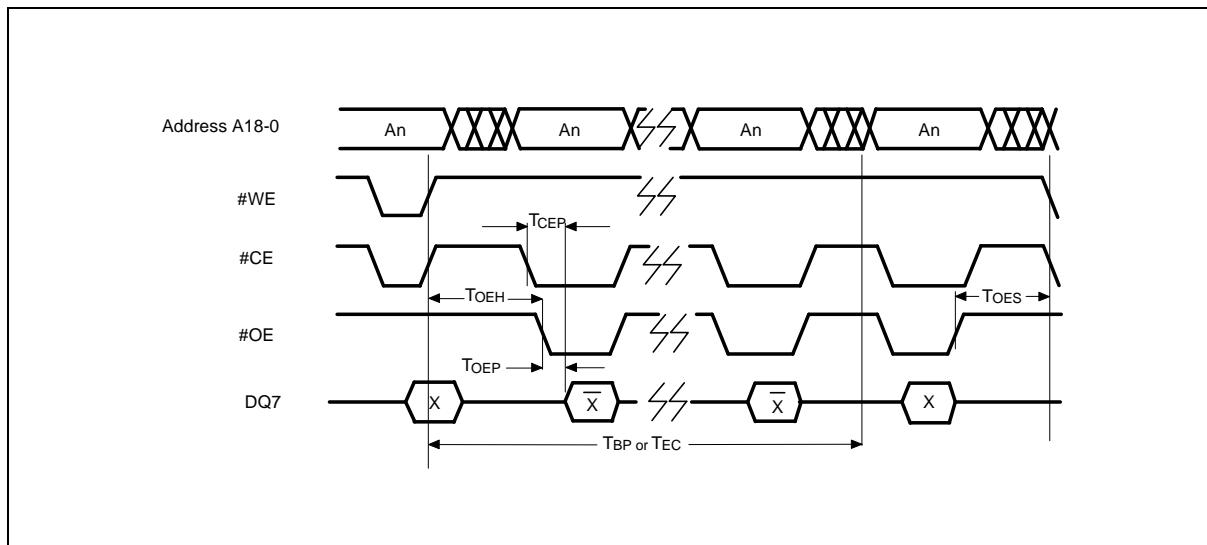


Timing Waveforms, continued

Sector/Page Erase Timing Diagram

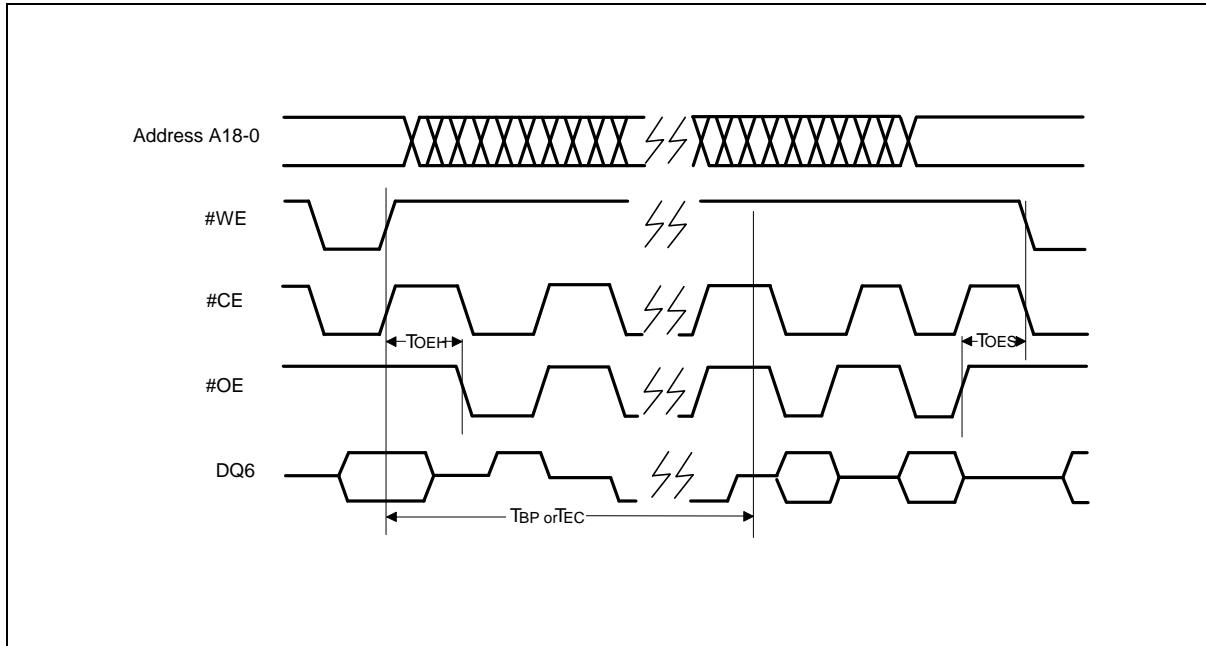


#DATA Polling Timing Diagram



Timing Waveforms, continued

Toggle Bit Timing Diagram



Preliminary W39L040



ORDERING INFORMATION

PART NO.	ACCESS TIME (nS)	POWER SUPPLY CURRENT MAX. (mA)	STANDBY V _{DD} CURRENT MAX. (mA)	PACKAGE	OPERATING TEMP. (°C)	CYCLE
W39L040P-70	70	20	2	32L PLCC	0 – 70	1K
W39L040P-90	90	20	2	32L PLCC	0 – 70	1K
W39L040T-70	70	20	2	32L TSOP (8 x 20 mm)	0 – 70	1K
W39L040T-90	90	20	2	32L TSOP (8 x 20 mm)	0 – 70	1K
W39L040Q-70	70	20	2	32L STSOP (8 x 14 mm)	0 – 70	1K
W39L040Q-90	90	20	2	32L STSOP (8 x 14 mm)	0 – 70	1K
W39L040P-70B	70	20	2	32L PLCC	0 – 70	10K
W39L040P-90B	90	20	2	32L PLCC	0 – 70	10K
W39L040T-70B	70	20	2	32L TSOP (8 x 20 mm)	0 – 70	10K
W39L040T-90B	90	20	2	32L TSOP (8 x 20 mm)	0 – 70	10K
W39L040Q-70B	70	20	2	32L STSOP (8 x 14 mm)	0 – 70	10K
W39L040Q-90B	90	20	2	32L STSOP (8 x 14 mm)	0 – 70	10K
W39L040P-70J	70	20	2	32L PLCC	-40 – 85	1K
W39L040P-90J	90	20	2	32L PLCC	-40 – 85	1K
W39L040T-70J	70	20	2	32L TSOP (8 x 20 mm)	-40 – 85	1K
W39L040T-90J	90	20	2	32L TSOP (8 x 20 mm)	-40 – 85	1K
W39L040Q-70J	70	20	2	32L STSOP (8 x 14 mm)	-40 – 85	1K
W39L040Q-90J	90	20	2	32L STSOP (8 x 14 mm)	-40 – 85	1K
W39L040P-70K	70	20	2	32L PLCC	-40 – 85	10K
W39L040P-90K	90	20	2	32L PLCC	-40 – 85	10K
W39L040T-70K	70	20	2	32L TSOP (8 x 20 mm)	-40 – 85	10K
W39L040T-90K	90	20	2	32L TSOP (8 x 20 mm)	-40 – 85	10K
W39L040Q-70K	70	20	2	32L STSOP (8 x 14 mm)	-40 – 85	10K
W39L040Q-90K	90	20	2	32L STSOP (8 x 14 mm)	-40 – 85	10K

Notes:

1. Winbond reserves the right to make changes to its products without prior notice.
2. Purchasers are responsible for performing appropriate quality assurance testing on products intended for use in applications where personal injury might occur as a consequence of product failure.



HOW TO READ THE TOP MARKING

Example: The top marking of 32-pin TSOP W39L040T-70



1st line: Winbond logo

2nd line: the part number: W39L040T-70

3rd line: the lot number

4th line: the tracking code: 149 O B SA

149: Packages made in '01, week 49

O: Assembly house ID: A means ASE, O means OSE, ...etc.

B: IC revision; A means version A, B means version B, ...etc.

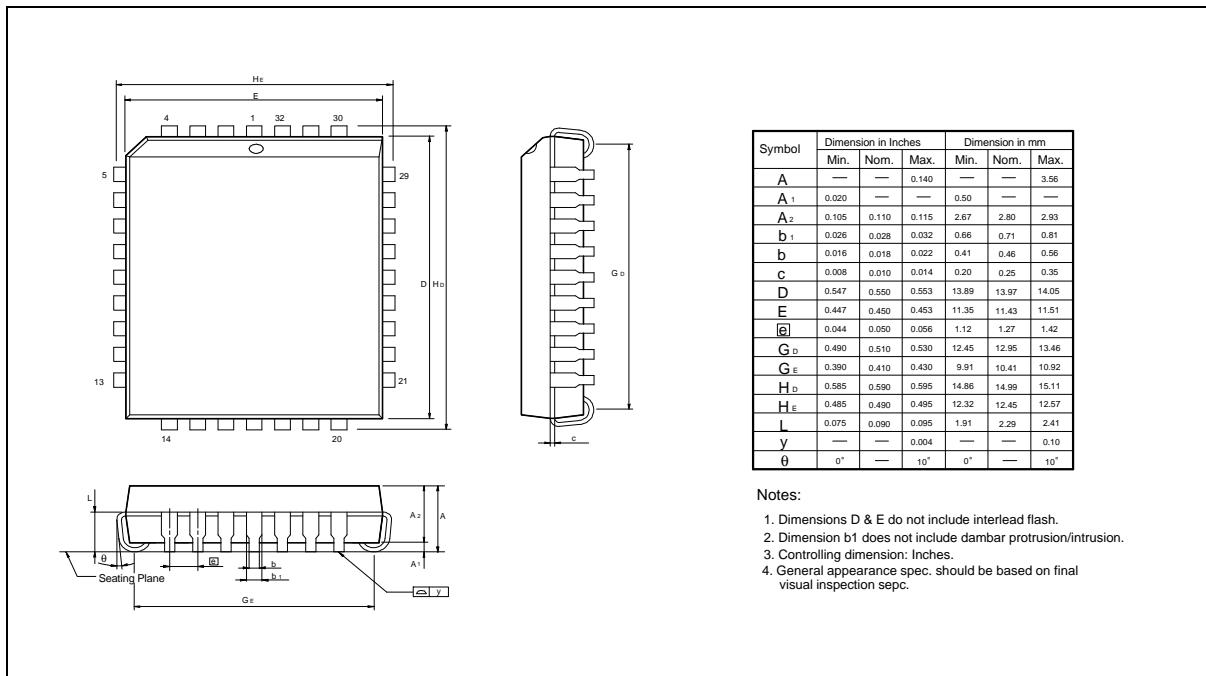
SA: Process code

Preliminary W39L040

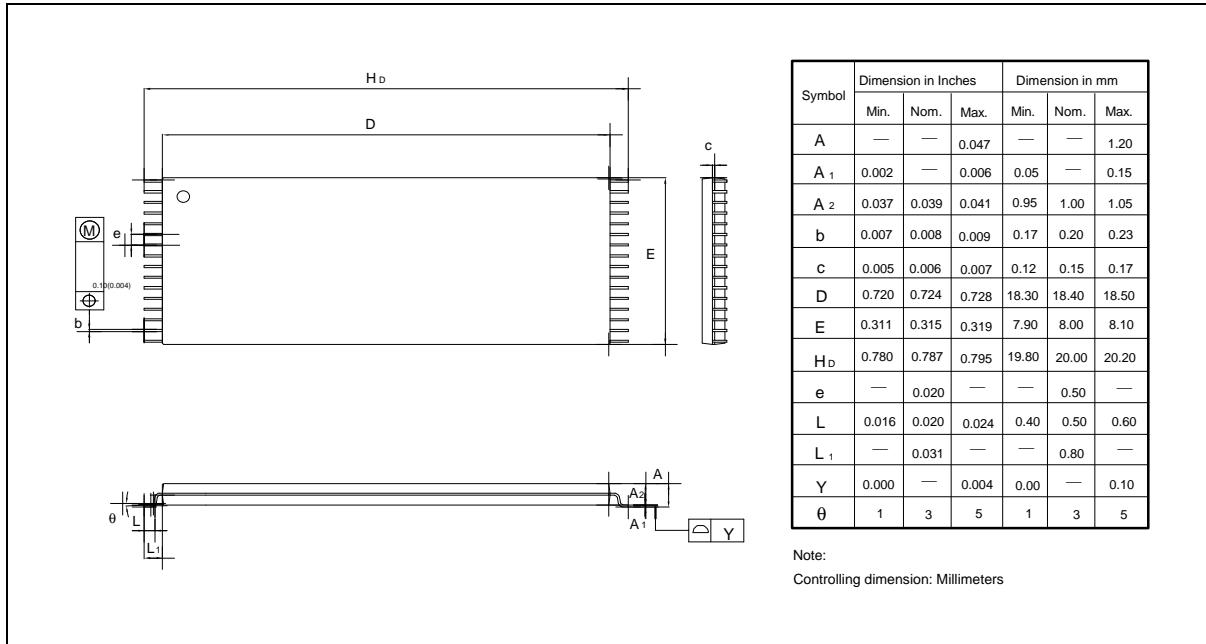


PACKAGE DIMENSIONS

32L PLCC



32L TSOP (8 x 20 mm)

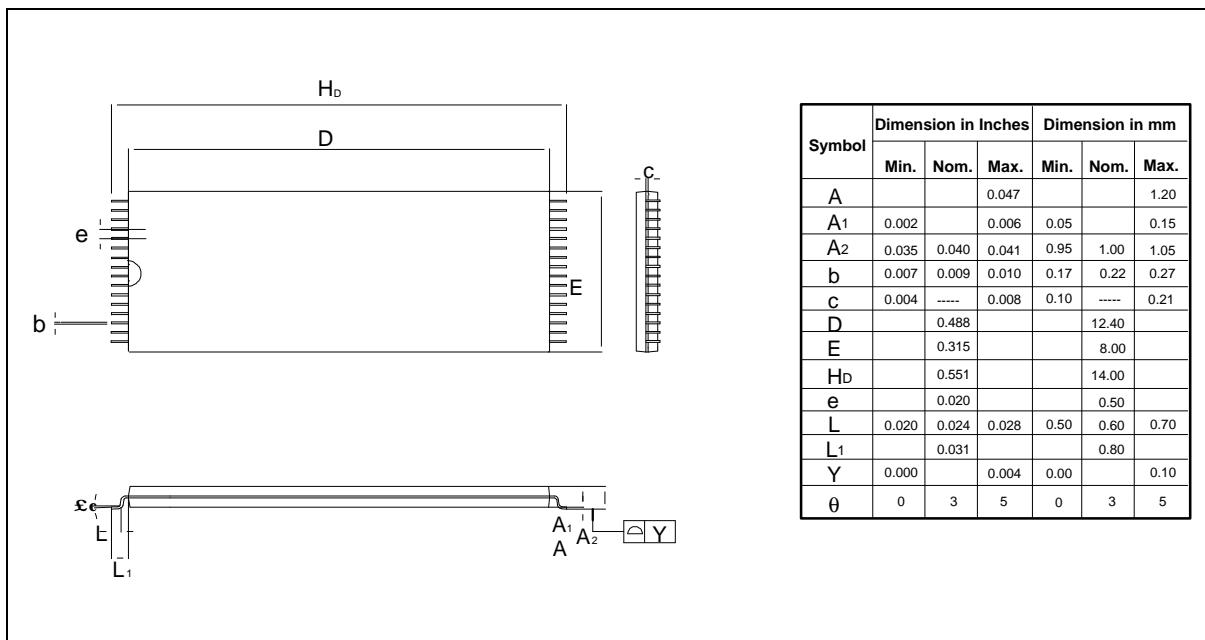


Preliminary W39L040



Package Dimensions, continued

32L STSOP (8 x 14 mm)



Preliminary W39L040



VERSION HISTORY

VERSION	DATE	PAGE	DESCRIPTION
A1	April 16, 2002	-	Initial Issued



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